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STS2DPF80

DUAL P-CHANNEL 80V - 0.21 Ω - 2.3A SO-8 STripFETTM POWER MOSFET

TYPE	V _{DSS}	R _{DS(on)}	I _D
STS2DPF80	80 V	<0.25 Ω	2.3 A

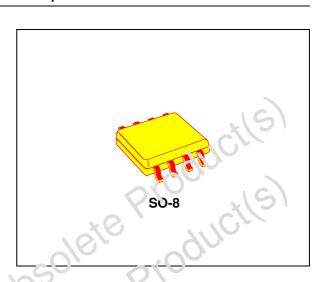
- TYPICAL $R_{DS}(on) = 0.21 \Omega$
- STANDARD OUTLINE FOR EASY AUTOMATED SURFACE MOUNT ASSEMBLY

DESCRIPTION

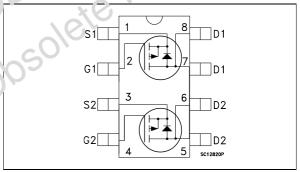
This application specific Power MOSFET is the second generation of STMicroelectronis unique "Single Feature SizeTM" strip-based process. The resulting transistor shows extremely high packing density for low on-resistance, rugged avalanche characteristics and less critical alignment steps therefore a remarkable manufacturing reproducibility.

APPLICATIONS

- DC/DC CONVERTERS
- BATTERY MANAGEMENT IN NOMADIC EQUIPMENT
- POWER MANAGEMENT IN CELLULAR PHONES AND DISPLAY NEW GENERATION



N'ERNAL SCHEMATIC DIAGRAM



Ordering 'nformation

SALES TYPE	MARKING	PACKAGE	PACKAGING
ST 38DPF80	S8DPF80	SO-8	TAPE & REEL

ABSOLUTE MAXIMUM RATINGS

Symbol	Parameter	Value	Unit
V _{DS}	Drain-source Voltage (V _{GS} = 0)	80	V
V _{DGR}	Drain-gate Voltage (R_{GS} = 20 $k\Omega$)	80	V
V _{GS}	Gate- source Voltage	± 20	V
I _D	Drain Current (continuous) at $T_C = 25^{\circ}$ C Single Operation Drain Current (continuous) at $T_C = 100^{\circ}$ C Single Operation	2.0 1.3	A A
I _{DM} (●)	Drain Current (pulsed)	8	Α
P _{tot}	Total Dissipation at T _C = 25°C	2.5	W
T _{stg}	Storage Temperature	-55 to 150	°C
Tj	Max. Operating Junction Temperature	150	°C

(•) Pulse width limited by safe operating area.

Note: For the P-CHANNEL MOSFET actual polarity of voltages and current has to be reversed

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TAB.1 THERMAL DATA

Rthj- _{PCB} (*)	Thermal Resistance Junction-PCB	62.5	°C/W
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 $^{(\}mbox{\ensuremath{}^{*}})$ When Mounted on 1 inch2 FR-4 board, 2 oz of Cu and t [10 sec.

ELECTRICAL CHARACTERISTICS (T_{CASE} = 25 °C UNLESS OTHERWISE SPECIFIED)

TAB.2 OFF

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Unit
V _{(BR)DSS}	Drain-source Breakdown Voltage	$I_D = 250 \ \mu A, \ V_{GS} = 0$	80			V
I _{DSS}	Zero Gate Voltage Drain Current (V _{GS} = 0)	$V_{DS} = Max Rating$ $V_{DS} = Max Rating T_C = 125^{\circ}C$			1 10	μΑ μΑ
I _{GSS}	Gate-body Leakage Current (V _{DS} = 0)	V _{GS} = ± 20 V		AI	±100	nA

TAB.3 ON (*)

Symbol	Parameter	Test Conditions		Min.	Тур.	Max.	Unit
V _{GS(th)}	Gate Threshold Voltage	$V_{DS} = V_{GS}$	I _D = 250 μ/\	2	A	4	٧
R _{DS(on)}	Static Drain-source On Resistance	V _{GS} = 10 V	I _D = 1 A	O	0.21	0.25	Ω

TAB.4 DYNAMIC

	Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Unit
	gfs (*)	Forward Transconductance	$v_{DS} = 10V$ $I_D = 1 A$		4		S
	C _{iss} C _{oss} C _{rss}	Input Capacitance Output Capacitance Reverse Transfer Capacitance		739 89.5 31		pF pF pF	
C	105018	ite Producit					

ELECTRICAL CHARACTERISTICS (continued)

TAB.5 SWITCHING ON

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Unit
t _{d(on)} t _r	Turn-on Delay Time Rise Time	$\begin{array}{ccc} V_{DD} = 40 \text{ V} & I_D = 1 \text{ A} \\ R_G = 4.7 \Omega & V_{GS} = 10 \text{ V} \\ \text{(Resistive Load, Figure 1)} \end{array}$		13.5 18		ns ns
Q _g Q _{gs} Q _{gd}	Total Gate Charge Gate-Source Charge Gate-Drain Charge	V_{DD} = 64V I_{D} = 2A V_{GS} =10V (See test circuit, Figure 2)		20 2.5 4.9		nC nC nC

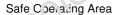
TAB.6 SWITCHING OFF

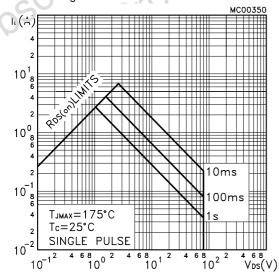
Symbol	Parameter	Test Conditions	Min.	Тур.	Max	Unit
t _{d(off)} t _f	Turn-off Delay Time Fall Time	$\begin{array}{ccc} V_{DD}=40 \text{ V} & I_D=1 \text{ A} \\ R_G=4.7\Omega, & V_{GS}=10 \text{ V} \\ \text{(Resistive Load, Figure 1)} \end{array}$		32 13	CL	ns ns

TAB.7 SOURCE DRAIN DIODE

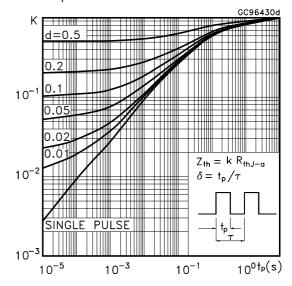
Symbol	Parameter	Test Conditions	Win.	Тур.	Max.	Unit
I _{SD} I _{SDM} (•)	Source-drain Current Source-drain Current (pulsed)	sole.	0	O_{O_j}	2.3 9.2	A A
V _{SD} (*)	Forward On Voltage	I _{SD} = 1 A \(\frac{1}{GS} = 0\)			1.2	V
t _{rr} Q _{rr} I _{RRM}	Reverse Recovery Time Reverse Recovery Charge Reverse Recovery Current	$I_{SD} = 2 \text{ A}$	Ö	47 87 3.7		ns nC A

^(*)Pulsed: Pulse duration = 300 μs, duty cycle 1.5 γ.
(•)Pulse width limited by safe operating area



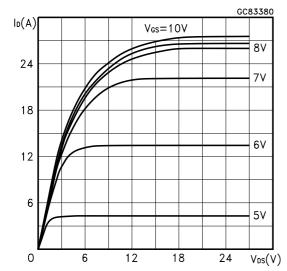


Thermal Impedance

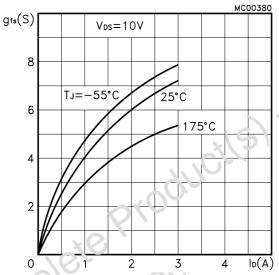


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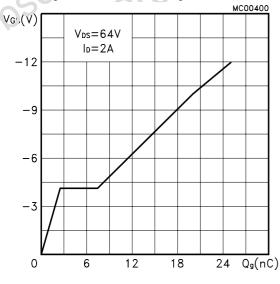
Output Characteristics



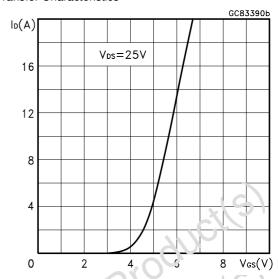
Transconductance



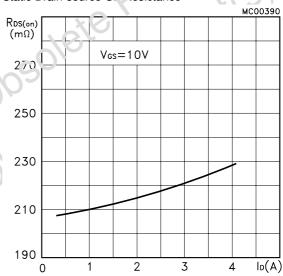
Gate Charge vs Gate-source Voltage



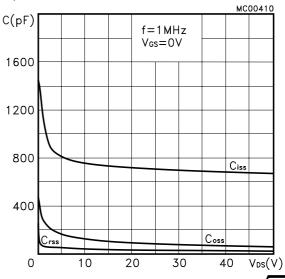
Transfer Characteristics



Static Drain-source On Flesistance

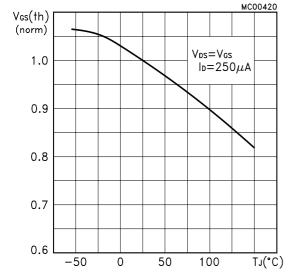


Capacitance Variations

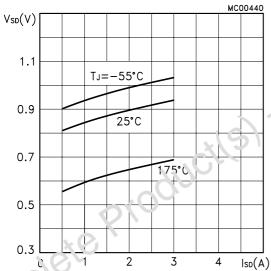


47/

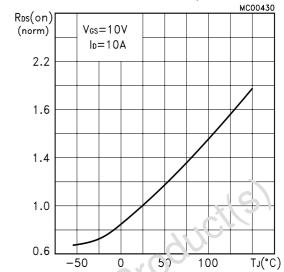
Normalized Gate Threshold Voltage vs Temperature



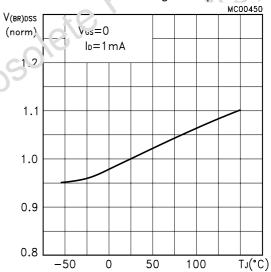
Source-drain Diode Forward Characteristics



Normalized on Resistance vs Temperature



Normalized Breaka יית Voltage Temperature.



0,0

Fig. 1: Switching Times Test Circuits For Resistive Load

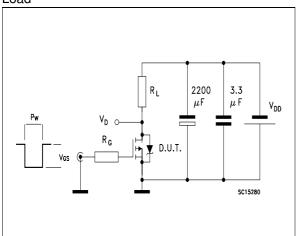


Fig. 2: Gate Charge test Circuit

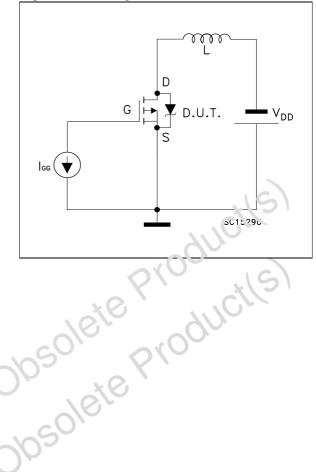
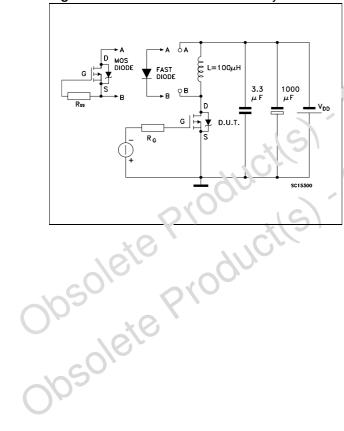
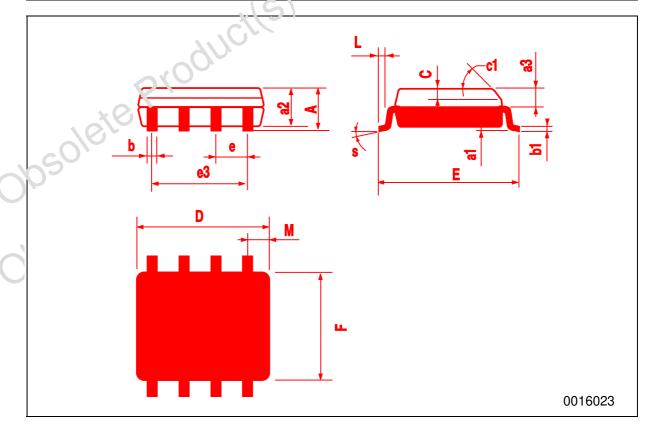


Fig. 3: Test Circuit For Diode Recovery Behaviour



SO-8 MECHANICAL DATA

DIM.		mm			inch	
DIWI.	MIN.	TYP.	MAX.	MIN.	TYP.	MAX.
Α			1.75			0.068
a1	0.1		0.25	0.003		0.009
a2			1.65			0.064
a3	0.65		0.85	0.025		0.033
b	0.35		0.48	0.013		0.018
b1	0.19		0.25	0.007		0.010
С	0.25		0.5	0.010		0.019
c1			45 (t	yp.)	AU	
D	4.8		5.0	0.188	- 100	0.196
E	5.8		6.2	0.228		0.244
е		1.27		× 0,	0.050	
e3		3.81		10,0	0.150	
F	3.8		4.0	0.14		0.157
L	0.4		1.27	0.015		0.050
М			0.6			0.023
S			8 (m	ax.)		



Revision History

Date	Revision	Description of Changes
Wednesday 16 June 2004	0.1	FIRST ISSUE

Obsolete Product(s) Obsolete Product(s)
Obsolete Product(s)
Obsolete Product(s)

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